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Team Nexperia



N-channel TrenchMOS logic level FET Rev. 02 — 26 April 2011

Product data sheet

Product profile 1.

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

AEC Q101 compliant

Low conduction losses due to low on-state resistance

1.3 Applications

Automotive and general purpose power switching

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	100	V
I _D	drain current	T _{mb} = 25 °C	-	-	11	А
P _{tot}	total power dissipation		-	-	54	W
Static cha	aracteristics					
R _{DSon}	on drain-source on-state resistance	V_{GS} = 10 V; I _D = 5 A; T _j = 25 °C	-	152	173	mΩ
re		$V_{GS} = 5 \text{ V}; \text{ I}_{D} = 5 \text{ A}; \text{ T}_{j} = 25 \text{ °C}$	-	165	180	mΩ
Avalanch	e ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\begin{split} I_D &= 5.5 \text{ A}; \text{V}_{\text{sup}} \leq 25 \text{V}; \\ R_{\text{GS}} &= 50 \Omega; \text{V}_{\text{GS}} = 5 \text{V}; \\ T_{j(\text{init})} &= 25 ^\circ\text{C}; \text{ unclamped} \end{split}$	-	-	1.5	mJ



N-channel TrenchMOS logic level FET

2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		-
2	D	drain	mb	
3	S	source	P ⊖ ſ	
mb	D	mounting base; connected to drain		mbb076 S

3. Ordering information

Table 3.Ordering information

Type number	Package		
	Name	Description	Version
BUK95180-100A	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78A

SOT78A (TO-220AB)

4. Limiting values

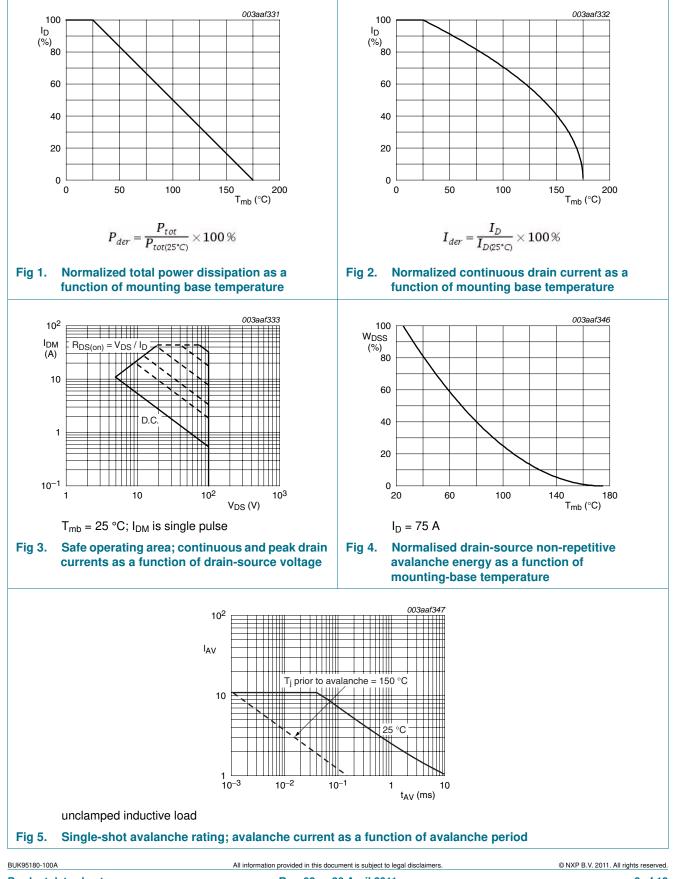
Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

		3, (
Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	100	V
V _{DGR}	drain-gate voltage	R_{GS} = 20 k Ω	-	100	V
V _{GS}	gate-source voltage		-15	15	V
I _D	drain current	T _{mb} = 25 °C	-	11	А
		T _{mb} = 100 °C	-	7.7	А
I _{DM}	peak drain current	T _{mb} = 25 °C; pulsed	-	44	А
P _{tot}	total power dissipation	T _{mb} = 25 °C	-	54	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Source-drai	in diode				
Is	source current	T _{mb} = 25 °C	-	11	А
I _{SM}	peak source current	pulsed; T _{mb} = 25 °C	-	44	А
Avalanche i	ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$I_D = 5.5 \text{ A}; V_{sup} \le 25 \text{ V}; R_{GS} = 50 \Omega;$ $V_{GS} = 5 \text{ V}; T_{j(init)} = 25 \text{ °C}; unclamped$	-	1.5	mJ

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Product data sheet

BUK95180-100A



N-channel TrenchMOS logic level FET

5. Thermal characteristics

Table 5.	I nermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base		-	-	2.8	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	-	60	-	K/W

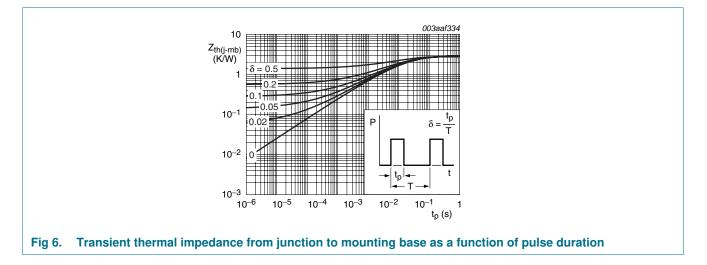


Table 5. Thermal characteristics

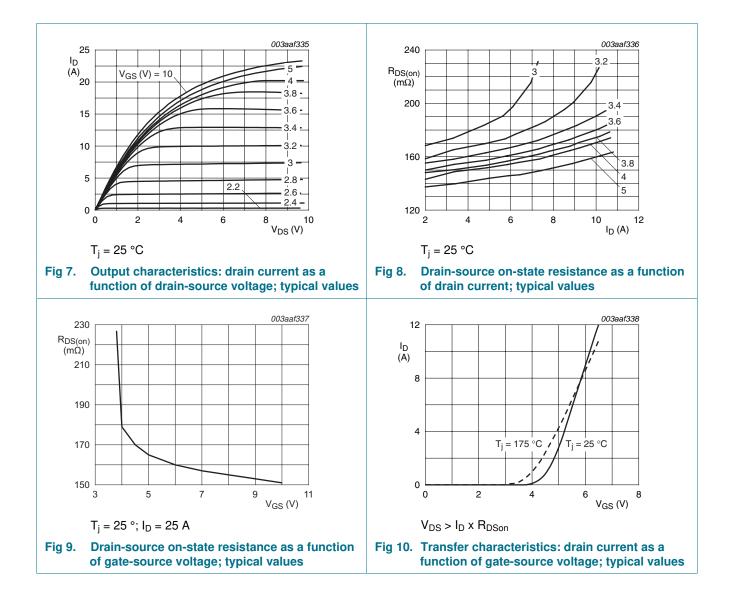
N-channel TrenchMOS logic level FET

6. Characteristics

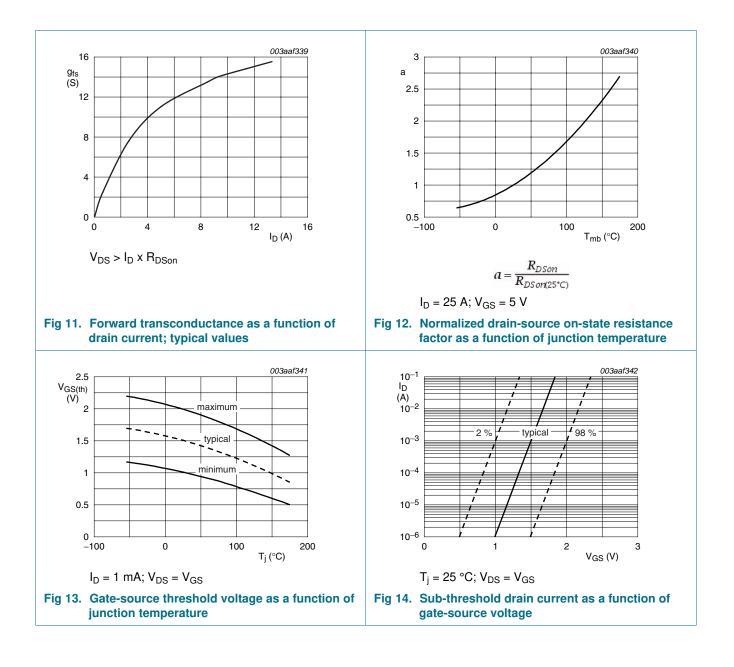
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	cteristics					
V _{(BR)DSS}	drain-source breakdown	I _D = 0.25 mA; V _{GS} = 0 V; T _i = 25 °C	100	-	-	V
	voltage	I _D = 0.25 mA; V _{GS} = 0 V; T _j = -55 °C	89	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}$	-	-	2.3	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	1	1.5	2	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C}$	0.5	-	-	V
I _{DSS}	drain leakage current	V_{DS} = 100 V; V_{GS} = 0 V; T_j = 175 °C	-	-	500	μA
		V_{DS} = 100 V; V_{GS} = 0 V; T_j = 25 °C	-	0.05	10	μA
GSS	gate leakage current	V_{GS} = 10 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
		V_{GS} = -10 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
R _{DSon} drain-source on-state resistance	drain-source on-state	$V_{GS} = 5 \text{ V}; \text{ I}_{D} = 5 \text{ A}; \text{ T}_{j} = 175 ^{\circ}\text{C}$	-	-	450	mΩ
	resistance	V_{GS} = 4.5 V; I_D = 5 A; T_j = 25 °C	-	170	200	mΩ
		V_{GS} = 10 V; I _D = 5 A; T _j = 25 °C	-	152	173	mΩ
		$V_{GS} = 5 \text{ V}; \text{ I}_{D} = 5 \text{ A}; \text{ T}_{j} = 25 \text{ °C}$	-	165	180	mΩ
Dynamic ch	aracteristics					
C _{iss}	input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$	-	464	619	pF
C _{oss}	output capacitance	$T_j = 25 \ ^{\circ}C$	-	60	72	pF
C _{rss}	reverse transfer capacitance		-	37	50	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 1.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$	-	9	20	ns
t _r	rise time	$R_{G(ext)} = 10 \ \Omega; T_j = 25 \ ^{\circ}C$	-	112	157	ns
t _{d(off)}	turn-off delay time		-	18	27	ns
t _f	fall time		-	25	38	ns
L _D	internal drain inductance	measured from drain lead 6 mm from package to centre of die ; $T_j = 25 \text{ °C}$	-	4.5	-	nH
		measured from contact screw on tab to centre of die ; $T_j = 25 \text{ °C}$	-	3.5	-	nH
-s	internal source inductance	measured from source lead to source bond pad ; $T_j = 25 \text{ °C}$	-	7.5	-	nH
Source-drai	n diode					
V _{SD}	source-drain voltage	$I_S = 5 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.85	1.2	V
		$I_{S} = 11 \text{ A}; V_{GS} = 0 \text{ V}; T_{j} = 25 \text{ °C}$	-	1.1	-	V
t _{rr}	reverse recovery time	$I_{S} = 11 \text{ A}; dI_{S}/dt = -100 \text{ A}/\mu\text{s};$	-	49	-	ns
Q _r	recovered charge	V_{GS} = -10 V; V_{DS} = 30 V; T_j = 25 °C	-	0.13	-	μC

BUK95180-100A Product data sheet

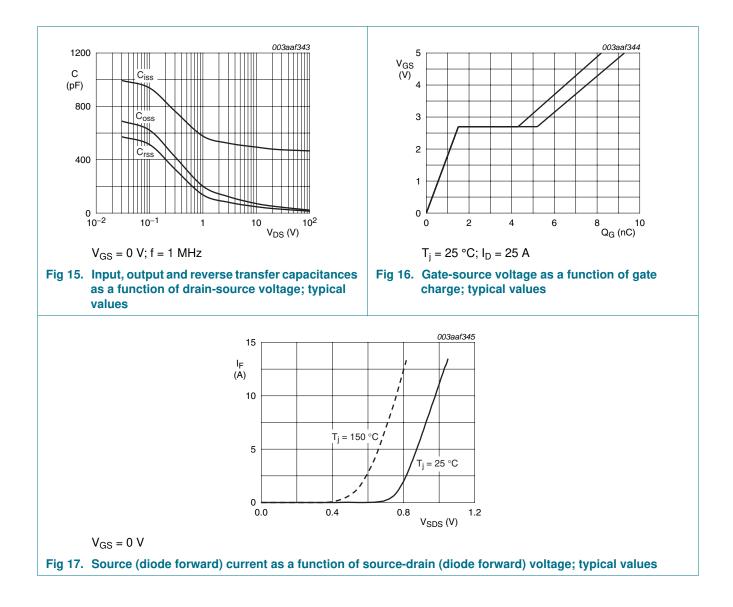
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N-channel TrenchMOS logic level FET

7. Package outline

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	4.5	A ₁ 1.39	0.9	V1 1.3	с 0.7	15.8	6.4	10.3		L 15.0	-1 ⁽¹⁾ 3.30	max.	р 3.8	q 3.0	2.6	-
mm	4.1	1.27	0.6	1.0	0.4	15.2	5.9	9.7	2.54	13.5	2.79	3.0	3.6	2.7	2.2	
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Fig 18. Package outline SOT78A (TO-220AB)

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BUK95180-100A

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8. Revision history

Table 7. Revision histo	ory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK95180-100A v.2	20110426	Product data sheet	-	BUK95180_96180-100A v.1
Modifications:		of this data sheet has b of NXP Semiconductors	0	omply with the new identity
	 Legal texts 	have been adapted to the	he new company nar	ne where appropriate.
	 Type number 	er BUK95180-100A sep	arated from data she	et BUK95180_96180-100A v.1.
BUK95180_96180-100A v	1 20000501	Product specification	-	-

N-channel TrenchMOS logic level FET

9. Legal information

9.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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BUK95180-100A

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